

TOSHIBA Field Effect Transistor Silicon N Channel MOS Type (π -MOSV)**2SK3407**

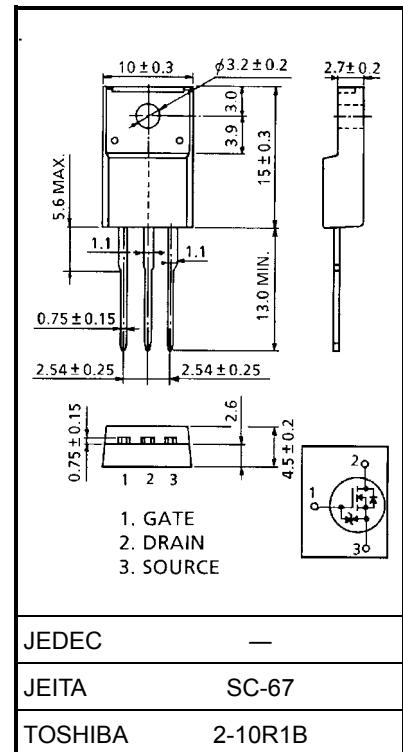
Switching Regulator Applications

Unit: mm

- Low drain-source ON resistance: $R_{DS\ (ON)} = 0.48\ \Omega$ (typ.)
- High forward transfer admittance: $|Y_{fs}| = 7.5\ S$ (typ.)
- Low leakage current: $I_{DSS} = 100\ \mu A$ (max) ($V_{DS} = 450\ V$)
- Enhancement-mode: $V_{th} = 2.4\sim 3.4\ V$ ($V_{DS} = 10\ V$, $I_D = 1\ mA$)

Maximum Ratings ($T_a = 25^\circ C$)

Characteristics	Symbol	Rating	Unit
Drain-source voltage	V_{DSS}	450	V
Drain-gate voltage ($R_{GS} = 20\ k\Omega$)	V_{DGR}	450	V
Gate-source voltage	V_{GSS}	± 30	V
Drain current	DC (Note 1)	I_D	10
	Pulse (Note 1)	I_{DP}	40
Drain power dissipation ($T_c = 25^\circ C$)	P_D	40	W
Single pulse avalanche energy (Note 2)	E_{AS}	222	mJ
Avalanche current	I_{AR}	10	A
Repetitive avalanche energy (Note 3)	E_{AR}	4	mJ
Channel temperature	T_{ch}	150	$^\circ C$
Storage temperature range	T_{stg}	-55~150	$^\circ C$



Weight: 1.9 g (typ.)

Thermal Characteristics

Characteristics	Symbol	Max	Unit
Thermal resistance, channel to case	$R_{th\ (ch-c)}$	3.125	$^\circ C/W$
Thermal resistance, channel to ambient	$R_{th\ (ch-a)}$	62.5	$^\circ C/W$

Note 1: Please use devices on condition that the channel temperature is below 150°C.

Note 2: $V_{DD} = 90\ V$, $T_{ch} = 25^\circ C$ (initial), $L = 3.7\ mH$, $R_G = 25\ \Omega$, $I_{AR} = 10\ A$

Note 3: Repetitive rating; pulse width limited by maximum channel temperature.

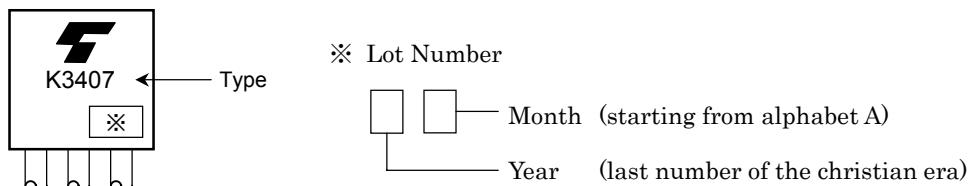
This transistor is an electrostatic sensitive device. Please handle with caution.

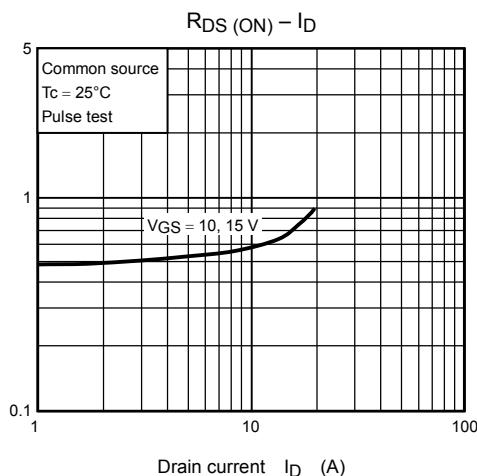
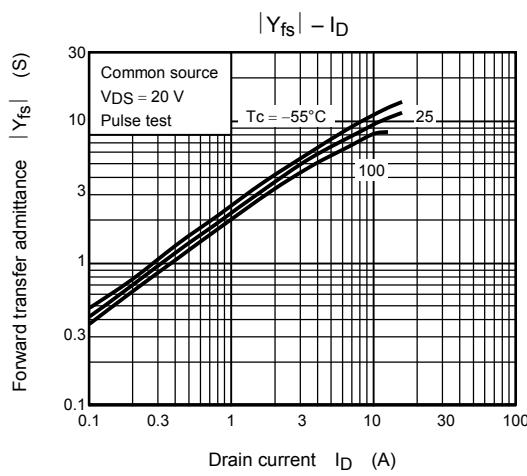
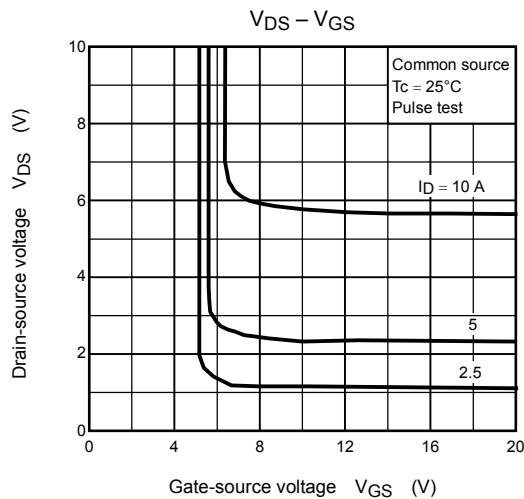
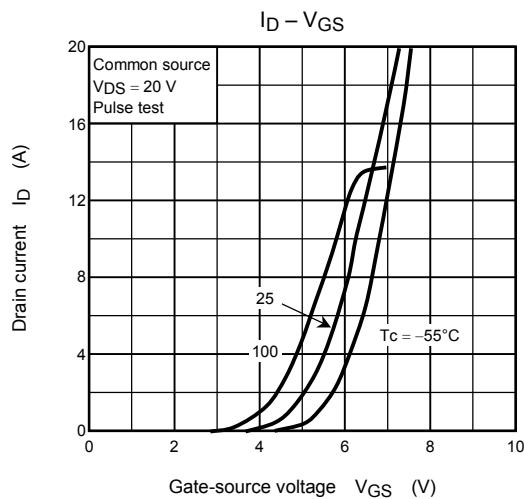
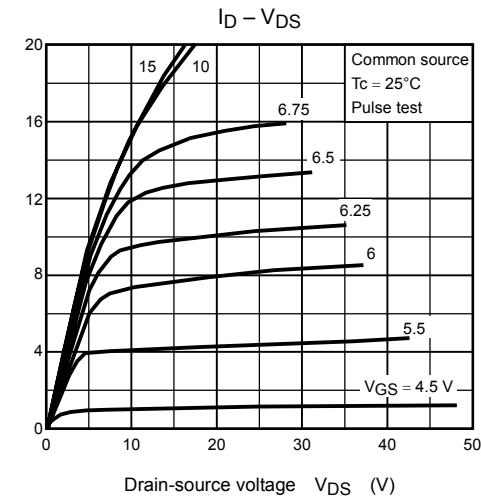
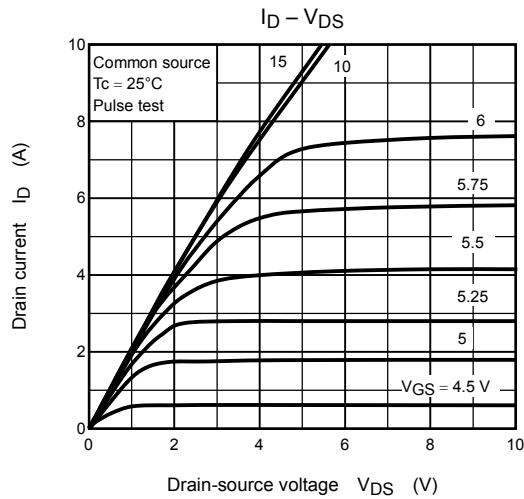
Electrical Characteristics (Ta = 25°C)

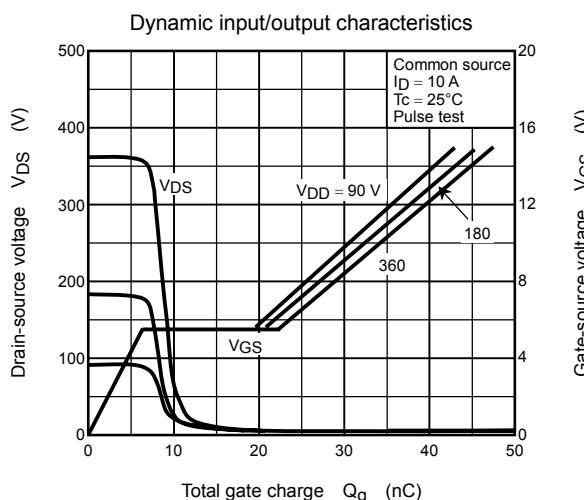
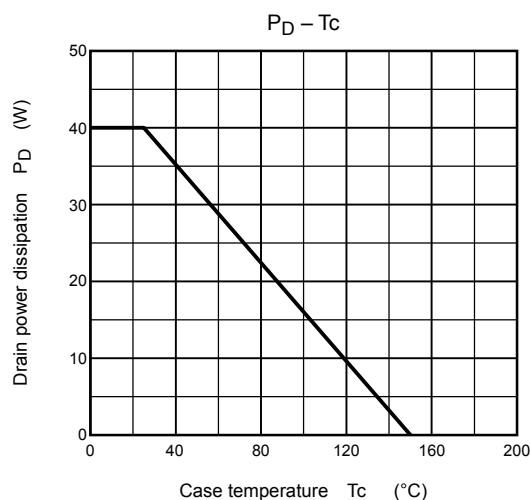
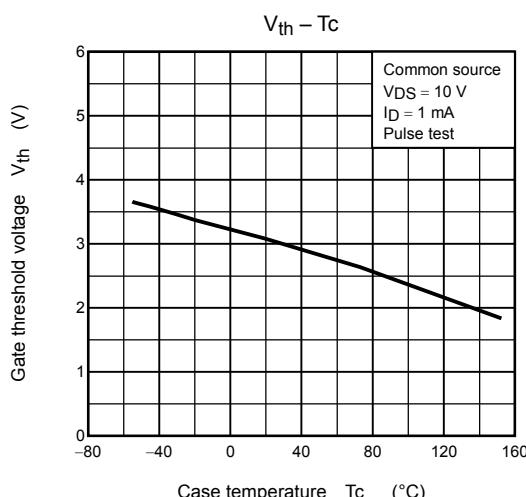
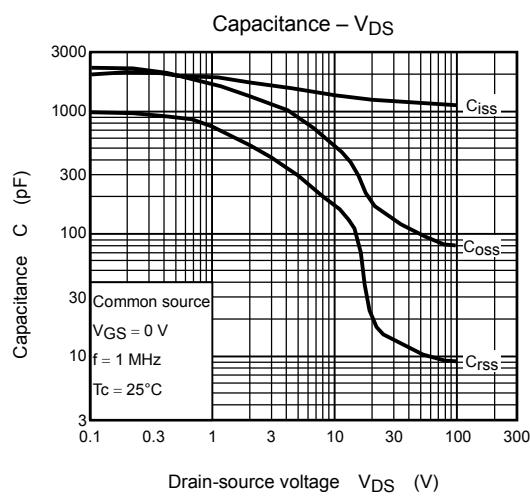
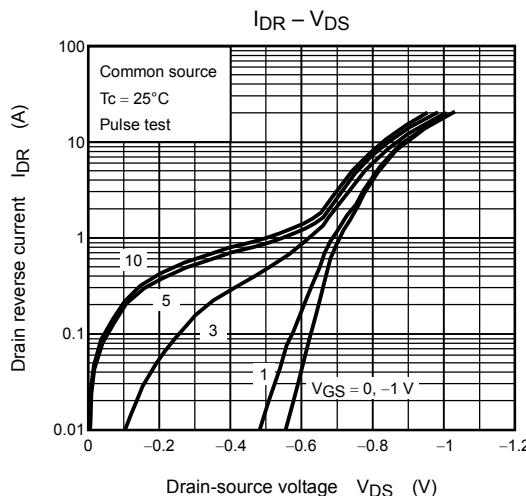
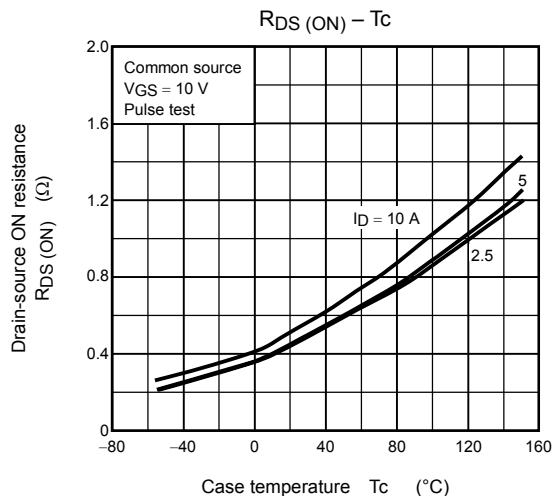
Characteristics	Symbol	Test Condition	Min	Typ.	Max	Unit
Gate leakage current	I _{GSS}	V _{GS} = ±25 V, V _{DS} = 0 V	—	—	±10	µA
Gate-source breakdown voltage	V _{(BR) GSS}	I _G = ±10 µA, V _{DS} = 0 V	±30	—	—	V
Drain cut-off current	I _{DSS}	V _{DS} = 450 V, V _{GS} = 0 V	—	—	100	µA
Drain-source breakdown voltage	V _{(BR) DSS}	I _D = 10 mA, V _{GS} = 0 V	450	—	—	V
Gate threshold voltage	V _{th}	V _{DS} = 10 V, I _D = 1 mA	2.4	—	3.4	V
Drain-source ON resistance	R _{DS} (ON)	V _{GS} = 10 V, I _D = 5 A	—	0.48	0.65	Ω
Forward transfer admittance	Y _{fs}	V _{DS} = 10 V, I _D = 5 A	3.5	7.5	—	S
Input capacitance	C _{iss}	V _{DS} = 10 V, V _{GS} = 0 V, f = 1 MHz	—	1400	—	pF
Reverse transfer capacitance	C _{rss}		—	240	—	
Output capacitance	C _{oss}		—	590	—	
Switching time	Rise time	t _r	 Duty $\leq 1\%$, $t_W = 10 \mu s$	—	35	—
	Turn-on time	t _{on}		—	50	—
	Fall time	t _f		—	80	—
	Turn-off time	t _{off}		—	260	—
Total gate charge (gate-source plus gate-drain)	Q _g	V _{DD} ≈ 360 V, V _{GS} = 10 V, I _D = 10 A	—	35	—	nC
Gate-source charge	Q _{gs}		—	19	—	
Gate-drain "miller" charge	Q _{gd}		—	16	—	

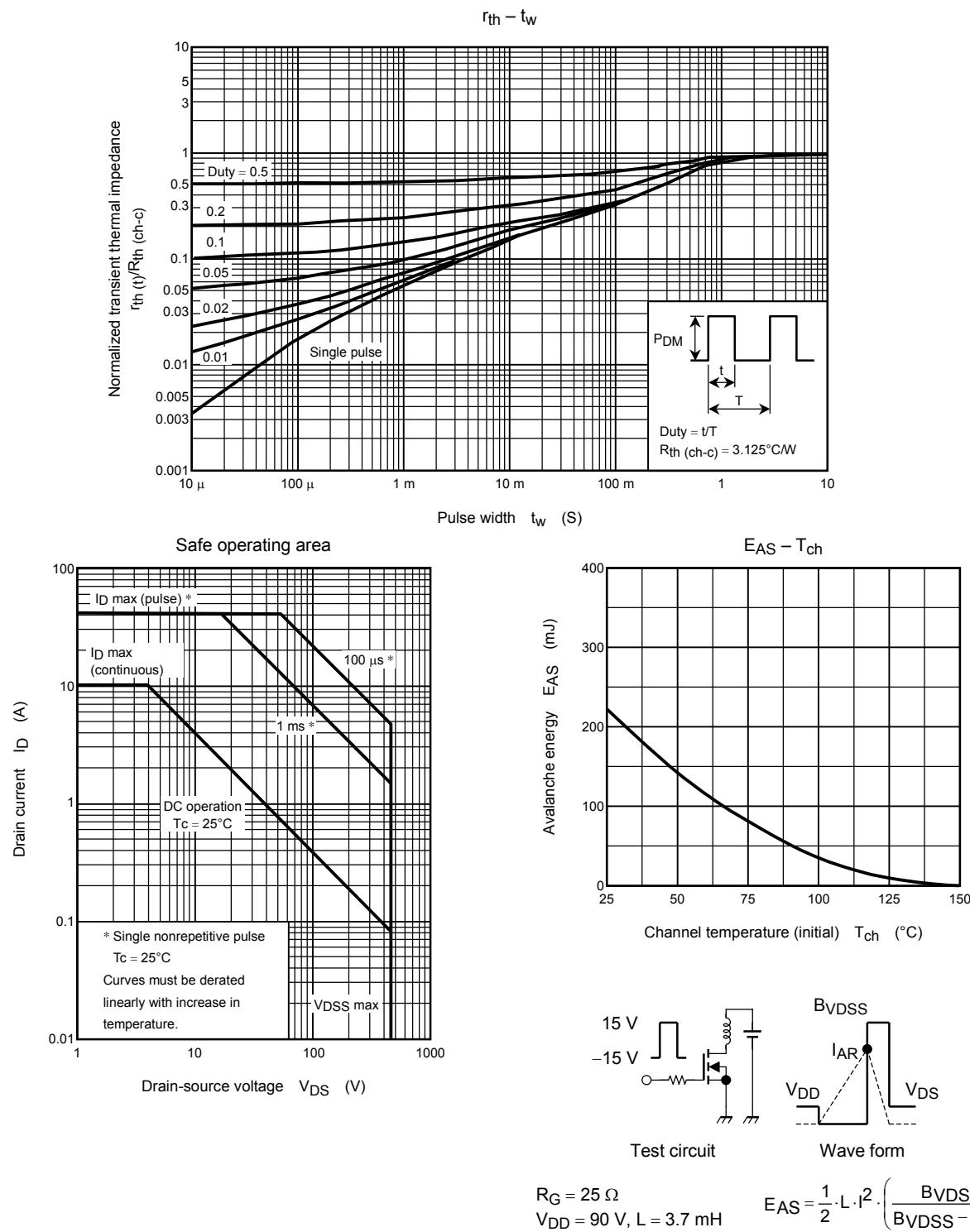
Source-Drain Ratings and Characteristics (Ta = 25°C)

Characteristics	Symbol	Test Condition	Min	Typ.	Max	Unit
Continuous drain reverse current (Note 1)	I _{DR}	—	—	—	10	A
Pulse drain reverse current (Note 1)	I _{DRP}	—	—	—	40	A
Forward voltage (diode)	V _{DSF}	I _{DR} = 10 A, V _{GS} = 0 V	—	—	-1.7	V
Reverse recovery time	t _{rr}	I _{DR} = 10 A, V _{GS} = 0 V, dI _{DR} /dt = 100 A/µs	—	280	—	ns
Reverse recovery charge	Q _{rr}		—	2.7	—	µC

Marking







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